# **High Capacitance Tantalum Solid Electrolytic Chip Capacitors Undertab Series**





#### **FEATURES**

- · Large Case Size for Maximum Capacitance
- · 3x Reflow 260°C Compatible
- 100% Surge Current Tested
- · Low Profile Solution
- Consumer Applications (e.g. PCMCIA/USB Wireless Express Cards etc.)
- CV Range: 1000-3300μF / 4-10V
- · 2 Case Sizes Available





#### **APPLICATIONS**

- · Data Transfer Modems
- · SSD Backup Circuits

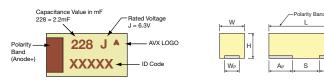
### **CASE DIMENSIONS:**

#### millimeters (inches)

Code	EIA Code	EIA Metric	L±0.20 (0.008)	W+0.20 (0.008) -0.10 (0.004)	H max.	W <sub>P</sub> ±0.10 (0.004)	W <sub>N</sub> ±0.10 (0.004)	A <sub>P</sub> ±0.10 (0.004)	A <sub>N</sub> ±0.10 (0.004)	S Min.
4	2924	7361-20	7.30 (0.287)	6.10 (0.240)	2.00 (0.079)	4.75 (0.187)	4.75 (0.187)	2.00 (0.079)	3.20 (0.126)	2.10 (0.083)
6	5831	14878-20	14.80 (0.583)	7.80 (0.307)	2.00 (0.079)	5.50 (0.217)	5.50 (0.217)	2.45 (0.096)	2.45 (0.096)	9.90 (0.390)

#### **MARKING**

#### **4,6 CASE**



#### **HOW TO ORDER**



#### **TECHNICAL SPECIFICATIONS**

Technical Data:			All technical data relate to an ambient temperature of +25°C						
Capacitance Range:			1000 μF to 3300 μF						
Capacitance Tolerance:			±20%						
Leakage Current DCL:		0.01CV							
Rated Voltage $(V_R)$ $-55^{\circ}C \le +40^{\circ}$		4	6.3	10					
Category Voltage (V <sub>c</sub> ) at 85°C:		2	3.2	5					
Category Voltage (V <sub>c</sub> ) at 125°C:		0.8	1.3	2					
Temperature Range:		-55°C to	+125°C v	vith cate	gory voltage				
Reliability:		$0.2\%$ per 1000 hours at 85°C, $0.5xV_R$ with $0.1\Omega/V$ series impedance with 60%							
confidence level									

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# CAPACITANCE AND RATED VOLTAGE RANGE (LETTER DENOTES CASE SIZE)

Capac	itance	Voltage Rating DC (VR) to 85°C							
μF	Code	4V (G)	6.3V (J)	10V (A)					
680	687								
1000	108			4(100)/6(55)					
1500	158		4(100)	6(55)					
2200	228		6(55)						
3300	338	6(55)							

Released ratings (ESR ratings in m0hms in parentheses)

Note: Voltage ratings are minimum values. AVX reserves the right to supply

higher voltage ratings in the same case size, to the same reliability standards.

#### **RATINGS & PART NUMBER REFERENCE**

AVX	Case Size	Capacitance (μF)	Rated Voltage (V)	Rated Temperature (°C)	Category Voltage (V)	Category Temperature (°C)	DCL Max. (µA)	ESR Max. @ 100kHz (mΩ)	100kHz RMS Current (mA)			
Part No.									25°C	85°C	125°C	MSL
4 Volt @ 40°C												
TLN6338M004#0055	6	3300	4	40	0.8	125	132	55	2045	1840	818	3
	6.3 Volt @ 40°C											
TLN4158M006#0100	4	1500	6.3	40	1.3	125	90	100	1285	1156	514	3
TLN6228M006#0055	6	2200	6.3	40	1.3	125	132	55	2045	1840	818	3
	10 Volt @ 40°C											
TLN4108M010#0100	4	1000	10	40	2	125	100	100	1285	1156	514	3
TLN6108M010#0055	6	1000	10	40	2	125	100	55	2045	1840	818	3
TLN6158M010#0055	6	1500	10	40	2	125	150	55	2045	1840	818	3

Moisture Sensitivity Level (MSL) is defined according to J-STD-020.

All technical data relates to an ambient temperature of +25°C. Capacitance and DF are measured at 120Hz, 0.5V RMS with a maximum DC bias of 2.2 volts.

DCL is measured at rated voltage after 5 minutes.

ESR allowed to move up to 1.25 times catalogue limit post mounting

DCL allowed to move up to 2.00 times catalogue limit post mounting

For typical weight and composition see page 274.

NOTE: AVX reserves the right to supply higher voltage ratings or tighter tolerance part in the same case size, to the same reliability standards.



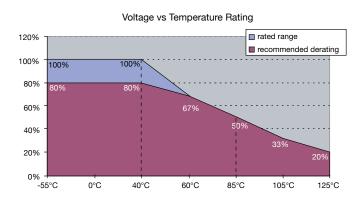
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### **QUALIFICATION TABLE**

TEST	TLN PulseCap™ series (Temperature range -55°C to +125°C)										
IESI		Condition	Characteristics								
	Apply rated voltage	ge (Ur) at 40°C and	Visual examination no visible damage								
Endurance		5°C for 2000 hours	DCL	2 x initia	2 x initial limit						
Endurance		.1Ω/V. Stabilize at re	ΔC/C	within +	within +5/-30% of initial value						
	for 1-2 hours befo	ore measuring.		ESR	1.25 x ir	1.25 x initial limit					
	Store at 65°C and	d 90-95% relative hu	Visual examination	no visib	no visible damage						
11		plied voltage. Stabi	,	DCL	2 x initia	2 x initial limit					
Humidity	temperature and	humidity for 1-2 ho	ΔC/C	within ±	within ±10% of initial value						
	measuring.		ESR	1.25 x ir	1.25 x initial limit						
	Step	Temperature°C	Duration(min)		+20°C	-55°C	+20°C	+85°C	+125°C	+20°C	
T	1 2	+20	15 15	DCL	2 x IL*	n/a	2 x IL*	20 x IL*	25 x IL*	2 x IL*	
Temperature Stability	3	+20	15	ΔC/C	_		±10%	+20/-0%		-	
Stability	<u>4</u> 5	+85 +125	15 15		n/a	+5/-20%		-,	+25/-0%	-	
	6	+20	15	ESR	1.25 x IL*	2.5 x IL*	1.25 x IL*	1.25 x IL*	1.25 x IL*	1.25xIL*	
	Apply 1.3x rated	voltage (Ur) at 40°C	Visual examination	no visib	no visible damage						
Surge	of duration 6 min	(30 sec charge, 5 r	DCL	2 x initia	2 x initial limit						
Voltage		gh a charge / discha	ΔC/C	within ±	within ±5% of initial value						
	of 1000Ω	ESR	1.25 x ir	1.25 x initial limit							
				Visual examination	no visib	no visible damage					
			DCL	initial lir	initial limit						
Mechanical Shock	MIL-STD-202, Method 213, Condition C			ΔC/C	within ±	within ±5% of initial value					
SHOCK				DF	initial lir	initial limit					
			ESR	initial lir	initial limit						
			Visual examination	no visible damage							
			DCL	initial lir	initial limit						
Vibration	MIL-STD-202, Me	MIL-STD-202, Method 204, Condition D			within ±	within ±5% of initial value					
				DF	initial lir	initial limit					
			ESR	initial lir	initial limit						

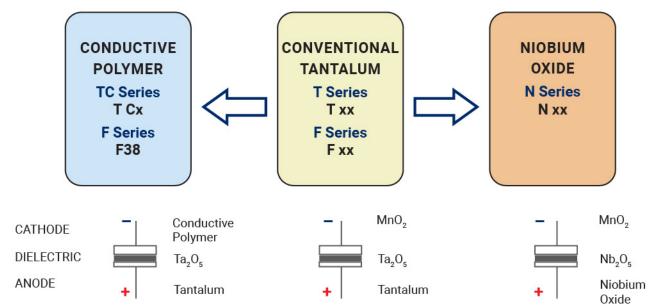
<sup>\*</sup>Initial Limit



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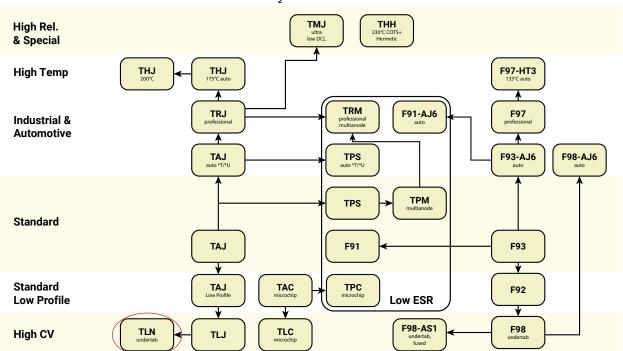
#### AVX SOLID ELECTROLYTIC CAPACITOR ROADMAP



#### **FIVE CAPACITOR CONSTRUCTION STYLES**



### SERIES LINE UP: CONVENTIONAL SMD MnO,



## 单击下面可查看定价,库存,交付和生命周期等信息

### >>AVX